Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/708,826	BEENAU ET AL.	
Examiner	Art Unit	
Nam V. Nguyen	2635	

SEARCHED				
Class	Subclass	Date	Examiner	
340	5.53	5/9/2006	NN	
340	5.2	5/9/2006	NN	
340	5.4+	5/9/2006	NN	
340	5.52	5/9/2006 NN		
340	5.6	5/9/2006	NN	
340	5.8+	5/9/2006	NN	
340	10.1	5/9/2006	NN	
340	10.4-10.5	5/9/2006	NN	
235	379	5/9/2006	NN	
235	380	5/9/2006 NN		
235	492	5/9/2006	NN	
705	35,54,76	5/9/2006	NN	
713	186	5/9/2006	NN	
713	194	5/9/2006	NN	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Search East: USPAT; US-PUB; EPO; JPO AND DERWENT. (UPDATED SEARCH)	5/9/2006	NN		
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